

Agilent 8657A/8657B **Signal Generators**

Profile

Spectral performance for general-purpose test

Overview

The Agilent Technologies 8657A and 8657B signal generators are designed to test AM, FM, and pulsed receivers as well as components. With their exceptional analog modulation, good spectral purity, and superb output level performance, these signal generators are ideal for R&D, manufacturing, and support.

In-channel performance Measurement confidence

The 8657A and B signal generators provide the spectral purity and modulation versatility needed for RF testing of communication and navigation equipment.

Low residual FM ensures wide hum and noise test margins

Hum and noise testing requires a signal generator to have low residual FM to ensure no measurement error. The residual FM of the 8657A and B provides the test margins you need for the most demanding hum and noise tests.

Output level range and accuracy for sensitivity testing

With a dynamic range from +13 to -143.5 dBm, the 8657A and B allow sensitivity measurements to be made on even the most sensitive receivers. The 8657A and B couple this with a level accuracy of ±1 dB (typically 0.5 dB) to -127 dBm across the full temperature range of 0 to 55 degrees C, to give you accurate and repeatable measurements every time.

Low RF leakage eliminates measurement interference

Sensitivity measurements can often be masked by RF leakage (radiated emissions). With the 8657A and B, RF leakage is reduced to a level that assures virtually no measurement interference.



DCFM faithfully reproduces digital signals

For radios with digital squelching, the 8657A and B have extremely stable dc-coupled FM (dcFM). The dc coupling of low-rate tones or digital data eliminates droop, and the exceptional stability and center-frequency accuracy when in dcFM mode eliminates the need to retune the signal generator after dcFM is selected.

Pulse modulation with the 8657B

High-performance pulse modulation (available on the 8657B) will give you confidence in your radar or pulsed carrier measurements. This includes rise/fall times of <35 ns, rates from dc to 30 MHz, and better than 70 dB on/off ratios (fc<1030 MHz).



Agilent Technologies

Out-of-channel measurements with the 8657A/B Low single-sideband phase noise for adjacent channel selectivity testing

A receiver's ability to reject unwanted signals is measured using out-of-channel tests. With its good spectral purity, the 8657A and B make it easy to perform demanding tests such as adjacent channel selectivity measurements.

Adjacent channel selectivity measures a receiver's ability to pick out a desired signal while rejecting a strong signal one channel away. To measure adjacent channel selectivity the out-of-channel signal generator must have low single-sideband (SSB) phase noise and nonharmonic spurious content at channel spacings, otherwise the inchannel signal is masked. The exceptional phase noise performance of the 8657A and B provides a cost-effective solution for many out-of-channel tests.

General purpose and component tests Output power to drive high-level inputs

For applications requiring high output power, the 8657A and B can overrange beyond the +13 dBm specified output level to >+16 dBm for most frequencies.

DCFM for VCO simulation

State-of-the-art dcFM and wide FM bandwidth make the 8657A and B ideal sources for many VCO simulation applications. For example, the 8657A or B can be used to replace a receiver's VCO during design.

Phase adjust to characterize phase-sensitive devices

The 8657A and B give you the ability to adjust the phase of the output signal in one-degree increments with respect to a source that is locked to the same reference timebase. This feature makes it easy to characterize phase-detector or phase-interferometer receivers during design or manufacturing.

Manual tests

100 nonvolatile store/recall registers save set-up time

The 8657A and B offer as a standard feature the ability to store 100 complete instrument states. This feature decreases set-up time when performing repetitive tests and reduces operator errors.

Register sequencing provides semi-automation

Stepping through the store/recall registers is easy with the front-panel sequence keys or the rear-panel remotesequence connector. These features allow the user to sequence through the storage registers in any order.

Automated tests Reliable output attenuators

With production lines requiring ever-faster throughput, test equipment must be more reliable than ever. Output level cycling requires electromechanical relays to switch in and out of different attenuators to produce varying output levels. The 8657A and B enhance system up-time by using a very reliable attenuator technology. The 8657A is especially dependable with its electronic attenuator design. Instead of using mechanical relays for switching the attenuators, the 8657A uses solid-state components for setting output levels. The patented design uses PIN-diode switching elements with 3 million hours mean time between failure rate. This exceptional reliability is backed with a 5-year warranty against attenuator failure.

Ordering information

Please contact your Agilent Technologies Sales and Service Office for more information or visit our website at www.agilent.com/find/tmdir

Option Description

- 001 High-stability timebase
- 002 Rear-panel connections
- 003 Pulse modulation (8657B only)
- 1BN Mil std 45662A calibration certification
- 1BP Mil std 45622A calibration with test data
- 907 Front handle kit
- 908 Rack flange kit
- 909 Rack flange kit w/ front handle
- 910 Adds operation/calibration manual and two service manuals
- 915 Adds service manual
- W30 3-year return repair service
- W32 3-year return calibration service
- W34 3-year standards compliant calibration service
- W50 5-year return repair service
- W52 5-year return calibration service
- W54 5-year standards compliant calibration service

Technical specifications

Specifications describe the instruments warranted performance and apply after a 30-minute warm-up. All specifications are valid over the signal generator's entire operating/environment range unless otherwise noted.

Supplemental characteristics (indicated by italic type) are intended to provide information useful in estimating instrument capability in your application by describing typical, but not warranted, performance.

Note: The upper frequency range of the 8657A is 1.04 GHz. Specifications above 1.04 GHz apply only to the 8657B.

Frequency

Range	
8657A	100 kHz to 1.04 GHz
8657B	100 kHz to 2.06 GHz
Underrange	To 10 kHz with uncalibrated output and modulation.
Resolution	
8657A	10 Hz
8657B	1 Hz
Accuracy and stability	Same as timebase
Switching speed ¹	<35 ms.² (30 ms typical at 25 °C)
Phase offset	Output signal phase is adjustable in 1-degree nominal increments.

Internal reference oscillator

Aging rate	Std. (typ.) ±2 ppm/yr	High-stability Option 001 8657A, 1.5 x 10 [®] parts/day after 10 days 1.0 x 10 [®] parts/day after 180 days 8657B, 1.0 x 10 [®] parts/day after 45 days
Temperature		
(0 to 55 °C)	±10 ppm	7 x 10 ^{.9}
Line voltage		2 x 10 ⁻⁹ (+5%, -10%)
Frequency	50 MHz	10 MHz
Timebase referenco output (rear panel)	9	Available at a level of >0.15 V_{rms} into 50 Ω (output of 10, 5, or 1 MHz is selec- table via internal jumper). If external ref- erence is used, output will be the same frequency.
External reference (rear panel)	input	Accepts any 10, 5, or 1 MHz ±0.002%) Frequency standard at a level >0.15 Vrms into 50 Ω

Output

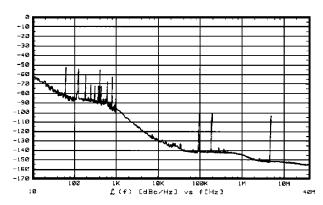
Range (dBm)	
8657A	+13 dBm to –143.5 dBm into 50 Ω ,
	+10 dBm to -143.5 dBm for frequencies
	from 100 kHz to 1 MHz
8657B	+13 dBm to -143.5 dBm into 50 Ω ,
	+10 dBm to –143.5 dBm with pulse
	modulation installed at f _c <1.03 GHz
Resolution	0.1 dB
Absolute level accuracy ³	
8657A	<±1.5 dB (>+7 dBm)
	<±1.0 dB (+7 to –127 dBm)
	<±1.5 dB (<-127 dBm)
8657B	<±1.5 dB (>+3.5 dBm)
	<±1.0 dB (+3.5 to -127 dBm)
	<±1.5 dB (<–127 dBm)
Level flatness	
100 kHz to 2.06 GHz	±0.5 dB, output level setting of 0 dBm
Reverse power protection	
to maximum output frequency)	50 watts (from a 50 Ω source)
Maximum DC voltage	8657A, 50 V
	8657B, 25 V
SWR	
8657A (fc(400 kHz)	<1.5 for levels <-3.5 dBm
	<2.0 for levels \leq +13 dBm
8657B	<1.5 for levels \leq -6.5 dBm
	<2.0 for levels ≤ +13 dBm
Output impedance	50 Ω nominal

To be within 100 Hz of carrier frequency.
Add 5 ms when switching to fc>1.03 GHz for the 8657B.

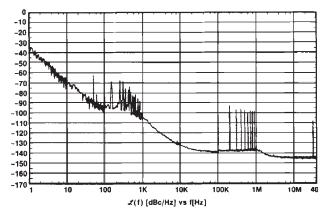
3. Absolute level accuracy includes allowances for detector linearity, temperature, flatness, attenuator accuracy and measurement uncertainty.

Spectral purity

SSB phase noise (in CW mode, at 20 kHz offset)			
<–124 dBc/Hz	(<–130 dBc/Hz, typical)		
<–136 dBc/Hz	(<–140 dBc/Hz, typical)		
<–130 dBc/Hz	(<–136 dBc/Hz, typical)		
<–124 dBc/Hz	(<–130 dBc/Hz, typical)		
<–118 dBc/Hz	(<–123 dBc/Hz, typical)		
	<-124 dBc/Hz <-136 dBc/Hz <-130 dBc/Hz <-124 dBc/Hz		



Typical Agilent 8657A SSB phase noise at 500 MHz



Typical Agilent 8657B SSB phase noise at 500 MHz

Residual FM (CW mode, rms)

Frequency range	Post detection BW (rms detector) 300 Hz to 3 kHz	50 Hz to 15 kHz ¹
0.1 to 130 MHz	<4 Hz (typical <2 Hz)	<6 Hz (typical <3 Hz)
130 to 260 MHz	<1 Hz (typical <0.5 Hz)	<1.5 Hz (typical <1 Hz)
260 to 520 MHz	<2 Hz (typical <1 Hz)	<3 Hz (typical <1 Hz)
520 MHz to1.04 GHz	8657A, <4 Hz <i>(typical <1 Hz)</i>	8657A, <6 Hz
	8657B, <3 Hz <i>(typical <1 Hz)</i>	8657B, <4 Hz (typical <1.5 Hz)
1.04 to 2.06 GHz	<6 Hz <i>(typical <2 Hz)</i>	<8 Hz (typical <3 Hz)

1. Typical residual FM specifications for the 50 Hz to 15 kHz post detection bandwidth apply only to the 8657B.

Residual AM (50 Hz to 15 kHz post-detection noise bandwidth, in CW mode)

<0.04% AM

Harmonics (\leq +7 dE	3m output levels)1	
8657A		<-30 dBc
8657B	0.1 to 1.03 GHz	<-30 dBc
	1.03 to 1.8 GHz	<-25 dBc
	1.8 to 2.06 GHz	<-25 dBc
Subharmonics (≤+)	7 dBm output levels)	
8657A, 8657B	0.1 to 1.03 GHz	None
8657B	1.03 to 1.8 GHz	<-40 dBc
	1.8 to 2.06 GHz	<35 dBc

Nonharmonics (CW mode)

Frequency range	Offset from carrier 5 kHz to 2 MHz	>2 MHz
0.1 to 130 MHz	8657A, <–60 dBc 8657B, <– <i>63 dBc (typical)</i>	<-60 dBc
130 to 260 MHz	8657A, <72 dBc 8657B, <75 dBc (typical)	<-60 dBc
260 to 520 MHz	8657A, <–66 dBc 8657B, <– <i>66 dBc (typical)</i>	<-60 dBc
520 MHz to 1.04 GHz	8657A, <-60 dBc 8657B, <- <i>63 dBc (typical)</i>	<-60 dBc
1.03 to 2.06 GHz	8657B, <–57 dBc (typical)	<54 dBc

Frequency modulation

Maximum FM peak deviation³

Center frequency 0.1 to 130 MHz	AC mode (the lesser of) 4000 x rate (Hz) or DC mode max. deviation	DC mode 8657A, 99 kHz 8657B, 200 kHz
130 to 260 MHz	1000 x rate (Hz) or DC mode max. deviation	8657A, 50 kHz 8657B, 50 kHz
260 to 520 MHz	2000 x rate (Hz) or DC mode max. deviation	8657A, 99 kHz 8657B, 100 kHz
520 MHz to 1.04 GHz	4000 x rate (Hz) or DC mode max. deviation	8657A, 99 kHz 8657B, 200 kHz
1.04 to 2.06 GHz	8000 x rate (Hz) or DC mode max. deviation	8657B, 400 kHz
Resolution		
8657A	100 Hz for deviations < 10 kHz 1 kHz for deviations \ge 10 kHz	
8657B	100 Hz (200 Hz for carrier frequ for deviations <20 kHz; 200 Hz (400 Hz for carrier frequ for deviations >20 kHz	. ,
FM rate Internal External	400 Hz and 1 kHz, ±2%	
(referenced to 1 kHz)	dc/5 Hz to 100 kHz, 3 dB band 50 kHz, 1 dB bandwidth	width; dc/20 Hz to

Spurious specifications apply for output levels ≤+4 dBm and f_c<1.03 GHz when pulse modulation is installed (8657B) only.
520 MHz to 1.03 GHz for 8657B.
FM not specified when peak deviation is >(f_c -100 kHz).

Center frequency accuracy in dc mode

Amplitude modulation

Carrier frequency	Center frequency	accuracy
0.1 to 130 MHz	±500 Hz	
130 to 260 MHz	±125 Hz	
260 to 520 MHz	±250 Hz	
520 MHz to 1.04 GHz	±500 Hz	
1.04 to 2.06 GHz	±1000 Hz	
Center frequency stability in dc mode	<10 Hz per hour drift (<i>hour)</i>	(typical <3 Hz per
Distortion (at internal rates) ¹	<0.5% THD plus noise all specified deviation	1 //
Sensitivity	1 V_{peak} for indicated accuracy, 1 V_{dc} when in dc-FM mode	
Indicator accuracy (internal rates) <±5% of setting	
Incidental AM (peak deviations		
<20 kHz, internal rates)	f _c >500 kHz	<0.1% AM
	$f_c > 1.03 \text{ GHz}^2$	<0.5% AM

Range 8657A ³ 8657B ⁵		$\begin{array}{l} 0 \text{ to } 99\%, \ \text{level} \leq \!$	
Resolution		1%	
Rates Internal External		400 Hz and 1 kHz 20 Hz to 40 kHz (8657B, typical, 20 (3 dB bandwidth)	1dB bandwidth); 7 <i>Hz to 100 kHz</i>
Distortion (interna	rates, level <	<+7 dBm)	
AM depth 0 to 30% AM 31 to 70% AM 71 to 90% AM	f _c <1.04 GHz <1.5% <3.0% <4.0%		f _e >1.04 GHz 4% 4% 7%

Sensitivity (typical) 1 $V_{\mbox{\tiny peak}}$ for indicated accuracy

+ 6% of setting)
adians peak

8657A only. FM distortion only specified for deviations up to 25 kHz for 130<fc<260 MHz, and for 260<fc<520 MHz.
8657B only.
AM depth is further limited by indicator accuracy specifications.
8657A only. For fc<400 kHz, AM depths of 0 to 30%, levels ≤+7 dBm.
8657B only. When pulse modulation is installed, maximum specified output level in AM is reduced by 3 dB when fc<1.03 GHz.

External modulation input

Front panel BNC, 600 Ω dc-coupled; front panel annunciators indicate 1 V peak signal ±5%.

Modulating signal output

Internal modulating signal is provided at the front panel BNC connector at nominally 1 V peak into a 600 Ω resistive load.

Simultaneous modulation

Internal/External	AM/FM, FM/AM, AM/AM, FM/FM,
	AM/FM/(Pulse')
Internal/Internal	AM/FM
External/External	AM/FM

Pulse modulation (Agilent 8657B only)¹

On/off ratio	
f _c ≥130 MHz	>70 dB
f _c ≥1.03 GHz	>95 dB
Rise/fall times	
f _c ≥130 MHz	>35 ns
f, ≥1.03 GHz	>50 ns

Maximum repetition rate	dc to 30 MHz, typical
Level accuracy	±1.0 dB, typical
Duty cycle	0 to 100%, typical (limited by rise/fall time)
Pulse modulation input	BNC, high impedance (internally selec- table to 50 ohms), can be driven directly by TTL
Maximum input level	±15 V, typical
Nominal input threshold	1.6 V, typical
Video feedthrough	<15%, typical
Pulse time delay ² On to off Off to on	34 ns, typical 47 ns, typical

Remote programming

Interface	GPIB (IEEE-488)
IEEE-488 functions	SH0, AH1, T0, L2, SR0, RL1, PP0, DC1, DT0, C0, E1

8657B only. Pulse modulation specifications apply for carriers >130 MHz and levels ≤+7 dBm (frequency switching speed typically increases by 30 ms with pulse modulation on). Additionally, AM is unspecified with pulse modulation turned on at fc≥1.03 GHz.
Time delay between a change in input pulse and carrier response.

General

Operating temperature range	0 to 55 °C
Storage temperature range	-40 to +71 °C
Leakage	Conducted and radiated interference is within the requirements of RE02 (and CE03 for the 8657B, except broadband conducted below 70 kHz) of MIL STD 461B, and FTZ 1046 (FTZ 1115 for 8657B). Furthermore, RF leakage of less than 1.0 μ V is induced in a two-turn loop, 2.5 cm in diameter, held 2.5 cm away from the front surface. (<i>Typical leakage for the 8657Bis <0.05 μV for levels <-40 dBm.)</i>
Save/recall/sequence storage registers	100 non-volatile registers are available to save front panel settings.
Rear-panel SEQ input level	TTL low to recall next storage register contents.
Power requirements	100 or 120 or 220 or 240 volts (+5%, -10% for 8657A; ±10% for 8657B) from 48 to 440 Hz; 160 VA maximum for 8657A (200 VA maximum for 8657B). IEC 1010 compliant.
Weight	8657A, net 18.2 kg (40 lb); shipping 23.6 kg (52 lb) 8657B, net 20.5 kg (45 lb); shipping 26.0 kg (57 lb)
Dimensions	133 mm H x 425 mm W x 574 mm D (5.25 in H x 16.75 in W x 22.6 in D)

By internet, phone, or fax, get assistance with all your test and measurement needs.

Online Assistance www.agilent.com/find/assist

Phone or Fax United States: (tel) 1 800 452 4844

Canada: (tel) 1 877 894 4414

(fax) (905) 206 4120 Europe:

(tel) (31 20) 547 2323 (fax) (31 20) 547 2390

Japan: (tel) (81) 426 56 7832 (fax) (81) 426 56 7840

Latin America: (tel) (305) 269 7500 (fax) (305) 269 7599

Australia: (tel) 1 800 629 485 (fax) (61 3) 9272 0749

New Zealand: (tel) 0 800 738 378 (fax) (64 4) 495 8950

Asia Pacific: (tel) (852) 3197 7777 (fax) (852) 2506 9284

Product specifications and descriptions in this document subject to change without notice.

Copyright © 1998, 2000 Agilent Technologies Printed in U.S.A. 8/00 5968-2704E

